## Notice of References Cited Application/Control No. 10/624,589 Applicant(s)/Patent Under Reexamination FURUKAWA ET AL. Examiner Sang Y Paik Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,151,871	09-1992	Matsumura et al.	700/300
	В	US-4,849,605	07-1989	Nakamori et al.	347/204
	С	US-5,560,851	10-1996	Thimm et al.	219/543
	D	US-6,133,557	10-2000	Kawanabe et al.	219/544
	Е	US-5,118,983	06-1992	Morita et al.	313/340
	F	US-5,554,839	09-1996	Tsuruta et al.	219/544
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	0					
	Р					,
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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